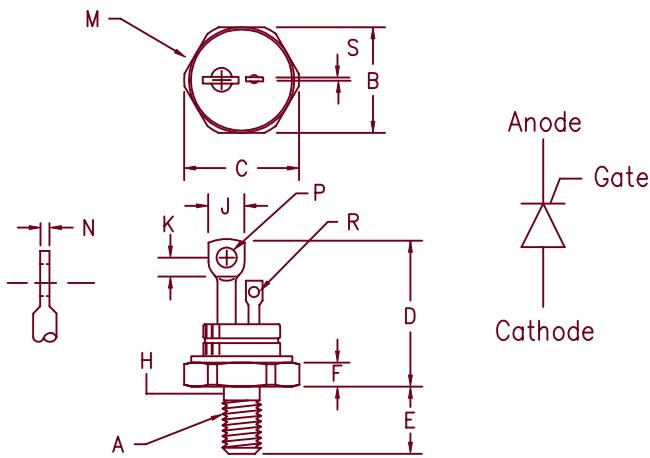


Silicon Controlled Rectifier Series 051



	Dim. Inches		Millimeter		
	Minimum	Maximum	Minimum	Maximum	Notes
A	---	---	---	---	1
B	.677	.685	17.20	17.40	
C	---	.770	---	19.56	
D	1.200	1.350	30.48	34.29	
E	.427	.455	10.84	11.55	
F	.115	.155	2.92	3.94	
G	---	.600	---	15.24	
H	.220	.249	5.58	6.32	2
J	.200	.300	5.08	7.62	
K	.120	---	3.05	---	
M	---	.680	---	17.27	Dia.
N	.030	.060	.762	1.52	
P	.170	.180	4.32	4.57	Dia.
R	.055	.065	1.40	1.65	Dia.
S	.025	.030	.64	.76	

Note 1: 1/4-28 UNF-3A

Note 2: Full thread within 2 1/2 threads

TO-208AC (TO-65) CERAMIC

Microsemi Catalog Number

Forward & Reverse Repetitive Blocking VDRM, VRRM

Reverse Transient Blocking

05102GOF	200	300
05104GOF	400	500
05106GOF	600	700
05108GOF	800	900
05110GOF	1000	1100
05112GOF	1200	1300

To specify dv/dt other than 200V/usec., contact factory.

- dv/dt=200 V/usec
- 1200 Amperes surge current
- Hi-Rel Ceramic Header

Electrical Characteristics

Max. RMS on-state current

$I_{T(RMS)}$ 80 Amps

$T_C = 94^\circ\text{C}$

Max. average on-state cur.

$I_{T(AV)}$ 50 Amps

$T_C = 94^\circ\text{C}$

Max. peak on-state voltage

V_{TM} 2.5 Volts

$I_{TM} = 500 \text{ A(peak)}$

Max. holding current

I_H 200 mA

$T_C = 94^\circ\text{C}$ 60Hz

Max. peak one cycle
surge current

I_{TSM} 1200 Amps

Max. I^2t capability for fusing

I^2t 6000A²S

$t = 8.3 \text{ ms}$

Thermal and Mechanical Characteristics

Operating junction temp range

T_J

-65°C to 150°C

Storage temperature range

T_{STG}

-65°C to 150°C

Maximum thermal resistance

$R_{\theta JC}$

0.35°C/W Junction to case

Typical thermal resistance (greased)

$R_{\theta CS}$

0.20°C/W Case to sink

Mounting torque

25-30 inch pounds

Weight

0.63 ounces (18 grams) typical

3-31-03 Rev. IR

051

$T_J = 25^\circ\text{C}$ unless otherwise indicated

Switching

Critical rate of rise of on-state current (note 1)	di/dt	200A/usec.	$T_J = 125^\circ\text{C}$
Typical delay time (note 1)	t_d	3.0 usec.	
Typical circuit commuted turn-off time (note 2)	t_q	100 usec.	$T_J = 125^\circ\text{C}$

Note 1: $I_{TM} = 50\text{A}$, $V_D = V_{DRM}$. $GT = 12\text{V}$ open circuit, 20Ω -0.1 usec. rise time
 Note 2: $I_{TM} = 50\text{A}$, $di/dt = 5\text{A}/\mu\text{s}$, V_R during turn-off interval = 50V min.,
 reapplied $dv/dt = 20\text{V}/\mu\text{s}$, linear to rated V_{DRM} , $V_{GT} = 0\text{V}$

Triggering

Max. gate voltage to trigger	V_{GT}	3.0V	
Max. nontriggering gate voltage	V_{GD}	0.25V	$T_J = 125^\circ\text{C}$
Max. gate current to trigger	I_{GT}	100mA	
Max. peak gate power	P_{GM}	10W	
Average gate power	$P_{G(AV)}$	1.0W	$t_p = 10 \mu\text{s}$
Max. peak gate current	I_{GM}	3.0A	
Max. peak gate voltage (forward)	V_{GM}	20V	
Max. peak gate voltage (reverse)	V_{GM}	10V	

Blocking

Max. leakage current	I_{DRM}	6mA	$T_J = 125^\circ\text{C} \& V_{DRM}$
Max. reverse leakage	I_{RRM}	6mA	$T_J = 125^\circ\text{C} \& V_{RRM}$
Critical rate of rise of off-state voltage	dv/dt	200V/ μs	$T_J = 125^\circ\text{C}$

Figure 1
Typical Forward On-State Characteristics

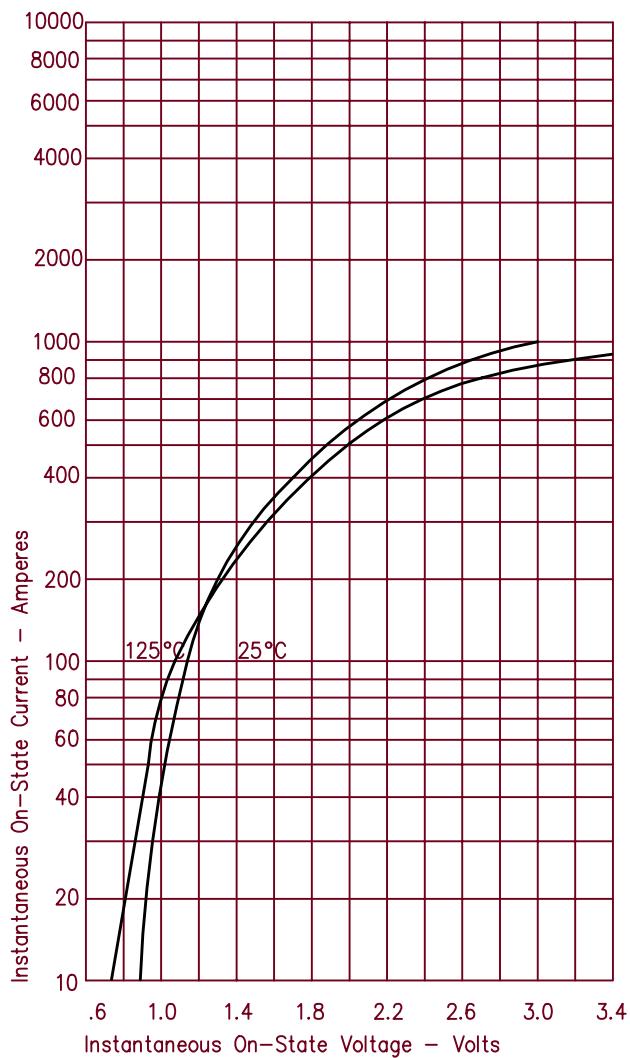


Figure 2
Forward Current Derating

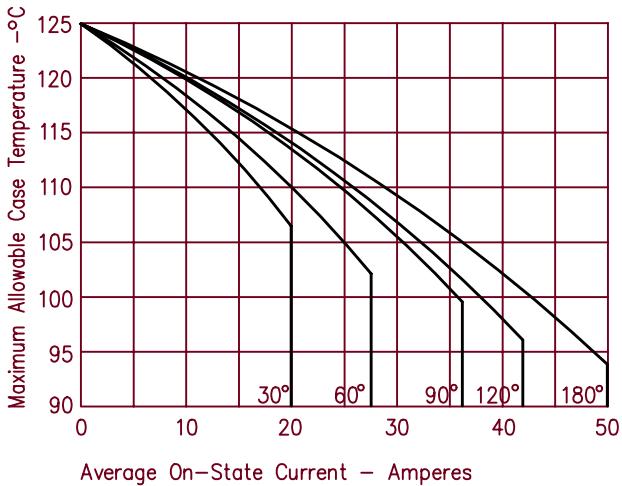


Figure 3
Maximum Power Dissipation

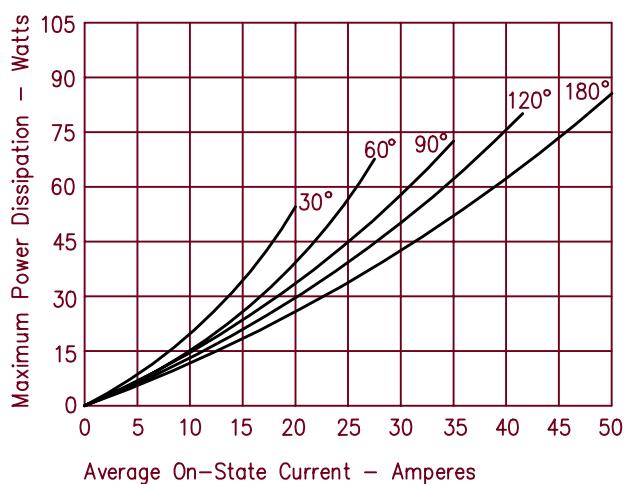


Figure 4
Transient Thermal Impedance

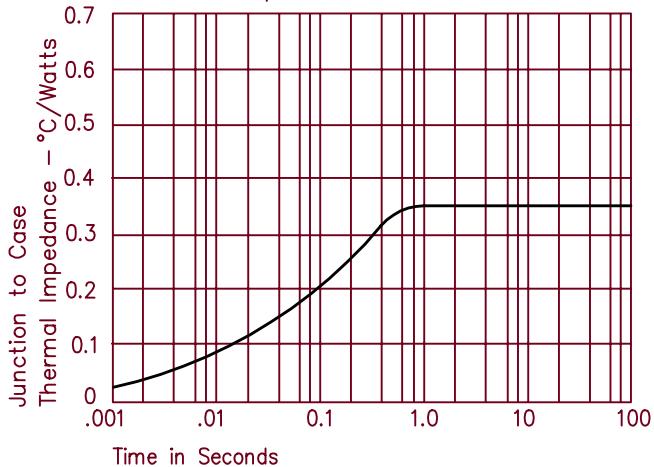


Figure 5
Maximum Nonrepetitive Surge Current

